Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/567,815	HAN ET AL.	
Examiner	Art Unit	
Scott D. Long	1633	

SEARCHED				
Class	Subclass	Date	Examiner	
	/	/		
	/			
<i>_</i>	/			
. /				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			-	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
PALM inventor search:  HAN, JAE LIM, JEONG MOOK LEE, YOUNG KIM, JIN NAM HONG, YEONG HAN, BEO	1/21/2008	SL	
EAST search: see attached sheets	1/21/2008	SL	
STN search: see attached sheets	1/21/2008	SL	